

**RoHS** 

HALOGEN FREE

# P-Channel 30 V (D-S) MOSFET

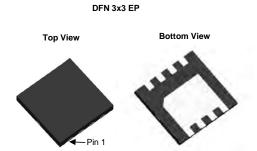
$V_{DS}$		-30	V
$R_{DS(on),typ}$	V <sub>GS</sub> =10V	11	mΩ
$R_{DS(on),typ}$	V <sub>GS</sub> =4.5V	18	mΩ
ID	-45	Α	

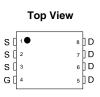
#### **FEATURES**

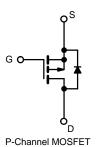
- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET<sup>®</sup> Power MOSFET
- Low Thermal Resistance PowerPAK<sup>®</sup>
   Package with Small Size and Low 1.07 mm
   Profile
- 100 %  $R_g$  and UIS Tested
- Compliant to RoHS Directive 2002/95/EC

#### **APPLICATIONS**

- · Load Switch
- · Adaptor Switch
- Notebook PC







Parameter	Symbol	Limit	Unit	
Drain-Source Voltage		V <sub>DS</sub>	- 30	V
Gate-Source Voltage		$V_{GS}$	± 20	v
	T <sub>C</sub> = 25 °C		- 45	
Continuous Drain Current (T <sub>.1</sub> = 150 °C)	T <sub>C</sub> = 70 °C		- 30	
Continuous Diami Current (1) = 150 C)	T <sub>A</sub> = 25 °C	l ID	- 14.4 <sup>a, b</sup>	
	T <sub>A</sub> = 70 °C		- 11.5 <sup>a, b</sup>	^
Pulsed Drain Current	I <sub>DM</sub>	- 60	A	
Continuous Courses Brain Binds Coursest	T <sub>C</sub> = 25 °C		- 35 <sup>e</sup>	
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	l <sub>S</sub>	- 3.2 <sup>a, b</sup>	
Avalanche Current	L = 0.1 mH	I <sub>AS</sub>	- 25	
Single-Pulse Avalanche Energy	L = 0.1 mm	E <sub>AS</sub>	31.25	mJ
	T <sub>C</sub> = 25 °C		52	
Maximum Dawar Dissination	T <sub>C</sub> = 70 °C	P <sub>D</sub>	43	w
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	' D	3.8 <sup>a, b</sup>	VV
	T <sub>A</sub> = 70 °C		2.4 <sup>a, b</sup>	
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	- 50 to 150	°C	
Soldering Recommendations (Peak Temperature) <sup>c, d</sup>		260		

### Notes:

- a. Surface mounted on 1" x 1" FR4 board.
- b. t = 10 s.
- c.Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- d.Package limited.
- e.Based on T  $_{\rm C}$  = 25  $^{\circ}{\rm C}$



THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient <sup>a, b</sup>	t ≤ 10 s	R <sub>thJA</sub>	26	33	°C/W
Maximum Junction-to-Case (Drain)	Steady State	R <sub>thJC</sub>	1.9	2.4	C/VV

#### Notes:

- a. Surface mounted on 1" x 1" FR4 board.
- b. Maximum under Steady State conditions is 81 °C/W.

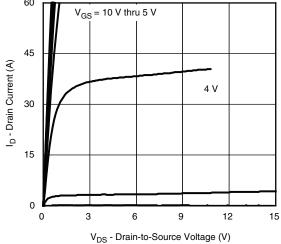
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	- 30			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = - 250 μA		- 20		mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	η = - 250 μΑ		5			
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 1.5		- 2.8	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zara Cata Valtaga Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = - 30 V, V <sub>GS</sub> = 0 V			- 1	, , Λ	
Zero Gate Voltage Drain Current		V <sub>DS</sub> = - 30 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			- 10	μΑ	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \le -5 \text{ V}, V_{GS} = -10 \text{ V}$	- 20			Α	
Durin Course Co Olete Besisters	В	V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 14.4 A		11		mC	
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 11.5 A		18		mΩ	
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = - 15 V, I <sub>D</sub> = - 14.4 A		37		S	
Dynamic <sup>b</sup>							
Input Capacitance	C <sub>iss</sub>			2000		pF	
Output Capacitance	C <sub>oss</sub>	$V_{DS} = -15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		385			
Reverse Transfer Capacitance	C <sub>rss</sub>			322			
Total Gate Charge	Qg	V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 14.4 A			15	14 7	
					14		
Gate-Source Charge	$Q_gs$	$V_{DS} = -15 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -14.4 \text{ A}$			7		
Gate-Drain Charge	$Q_gd$				9		
Gate Resistance	$R_g$	f = 1 MHz	0.4	1.8	3.6	Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			50	75		
Rise Time	t <sub>r</sub>	$V_{DD}$ = - 15 V, $R_L$ = 1.5 $\Omega$		43	65		
Turn-Off DelayTime	t <sub>d(off)</sub>	$I_D \cong$ - 10 A, $V_{GEN}$ = - 4.5 V, $R_g$ = 1 $\Omega$		30	45		
Fall Time	t <sub>f</sub>			14	21		
Turn-On Delay Time	t <sub>d(on)</sub>			14	21	ns	
Rise Time	t <sub>r</sub>	$V_{DD} = -15 \text{ V}, R_{L} = 1.5 \Omega$		9	18		
Turn-Off DelayTime	t <sub>d(off)</sub>	$I_D \cong$ - 10 A, $V_{GEN}$ = - 10 V, $R_g$ = 1 $\Omega$		36	54		
Fall Time	t <sub>f</sub>			10	20		
<b>Drain-Source Body Diode Characterist</b>	ics						
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			- 35 <sup>e</sup>	Α	
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				- 60	_ ^	
Body Diode Voltage	$V_{SD}$	I <sub>F</sub> = - 10 A		- 0.8	- 1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>			31	47	ns	
Body Diode Reverse Recovery Charge	$Q_{rr}$	I <sub>F</sub> = - 10 A, dl/dt = 100 A/μs, T <sub>.J</sub> = 25 °C		30	45	nC	
Reverse Recovery Fall Time	t <sub>a</sub>	$\frac{1}{1} = \frac{1}{1} = \frac{1}$		15			
Reverse Recovery Rise Time	t <sub>b</sub>	]		16		ns	

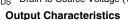
#### Notes:

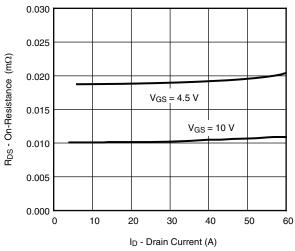
- a. Pulse test; pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2 %.
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

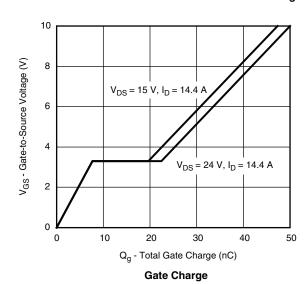








On-Resistance vs. Drain Current and Gate Voltage



1.2

(v) tueur 0.9

1.25 °C

25 °C

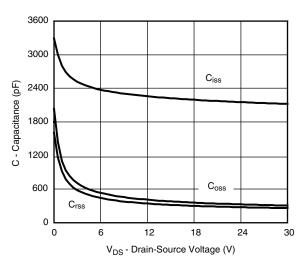
- 55 °C

0.0

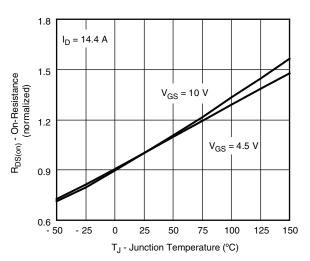
0 1 2 3 4

V<sub>GS</sub> - Gate-to-Source Voltage (V)

**Transfer Characteristics** 

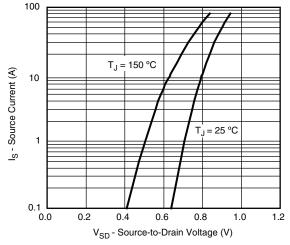


Capacitance

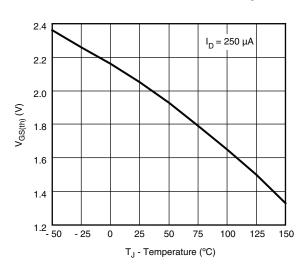


On-Resistance vs. Junction Temperature

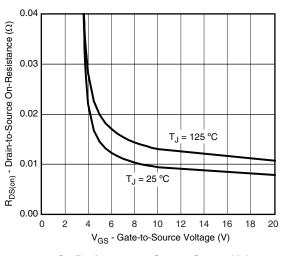




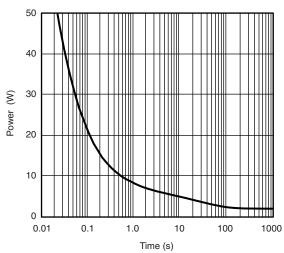




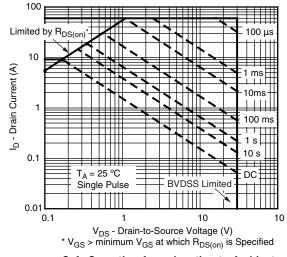
**Threshold Voltage** 



On-Resistance vs. Gate-to-Source Voltage



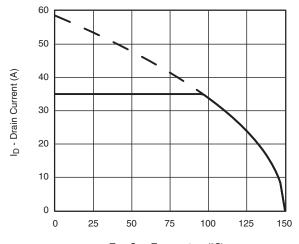
Single Pulse Power, Junction-to-Ambient



Safe Operating Area, Junction-to-Ambient

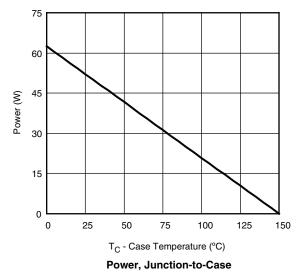
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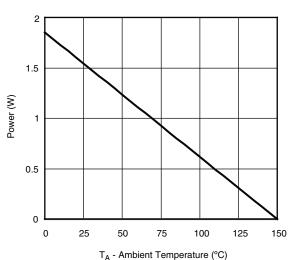




 $T_{\mbox{\scriptsize C}}$  - CaseTemperature (°C)

#### **Current Derating\***

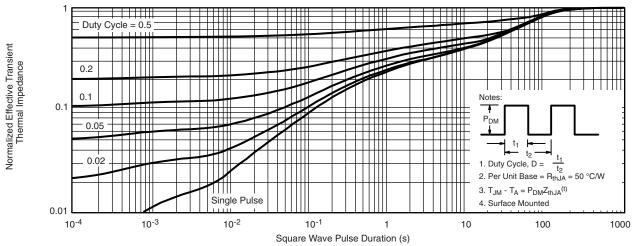




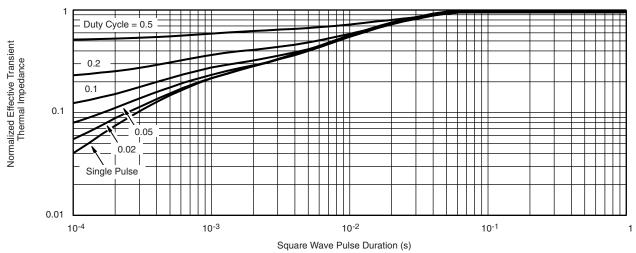
Power, Junction-to-Ambient

<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient

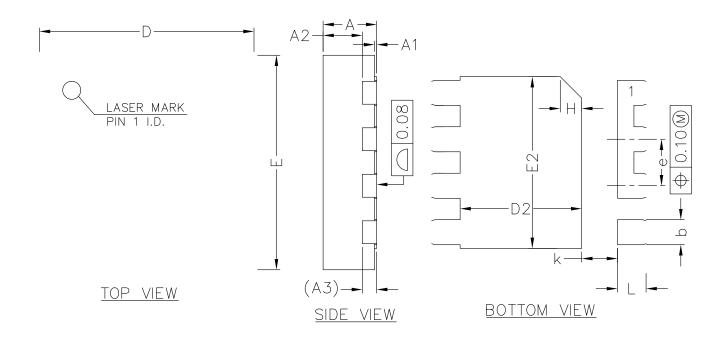


Normalized Thermal Transient Impedance, Junction-to-Case

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6







COMMON DIMENSIONS
(UNITS OF MEASURE=MILLIMETER)

SYMBOL	MIN	NOM	MAX
А	0.70	0.75	0.80
A1	0.00	0.02	0.05
A2	0.50	0.55	0.60
А3		0.20REF	
Ь	0.30	0.35	0.40
D	2.90	3.00	3.10
E	2.90	3.00	3.10
D2	1.60	1.70	1.80
E2	2.30	2.40	2.50
е	0.55	0.65	0.75
K	0.40	0.50	0.60
L	0.35	0.40	0.45



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DMN2080UCB4-7 DMN61D9UWQ-13 US6M2GTR DMN31D5UDJ-7 DMP22D4UFO-7B DMN1006UCA6-7 DMN16M9UCA6-7
STF5N65M6 IRF40H233XTMA1 STU5N65M6 DMN6022SSD-13 DMN13M9UCA6-7 DMTH10H4M6SPS-13 DMN2990UFB-7B
IPB80P04P405ATMA2 2N7002W-G MCAC30N06Y-TP MCQ7328-TP BXP7N65D BXP4N65F AOL1454G WMJ80N60C4 BXP2N20L
BXP2N65D BXT1150N10J BXT1700P06M TSM60NB380CP ROG RQ7L055BGTCR DMNH15H110SK3-13 SLF10N65ABV2
BSO203SP BSO211P IPA60R230P6 IPA60R460CE